MechDefect Solutions

Report 3
Presented by Group 15

Date	Duration of meet	Purpose of Meet	Presentees
15/10/2023	1 hour	Reviewing existing technical literature	ALL
17/10/2023	2 hours	Discussing AL/ML model scheme	ALL
18/10/2023	2 hours	Final report making	ALL

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Project Title and Objectives

Advanced AI-Driven Defect Detection Solutions for Manufacturing Excellence

Objectives:

- Develop Al-powered defect detection and classification solutions for industries that cater to the initial stages of manufacturing
- Leverage transfer learning by training our model on different processes (like casting, mining, etc) gaining knowledge from one and applying it to other processes.

Technical Background

Patents in the area

- <u>Unified neural network for defect detection and classification</u>
 - Their system includes several computer subsystems which use a neural network to detect and classify defects on a specimen's images.
 - and classify defects on a specimen's images.

 The network analyzes specimen images by extracting features in order to to identify and categorize defects.
- Training a machine learning model with synthetic images
 - This patent introduces methods for training ML models using synthetic defect images, employing a system that includes a user-friendly GUI.
 - The system allows users to edit and store modified images in a training set, facilitating ML model training.

Published literature in the area

- <u>Detection and Segmentation of Manufacturing Defects</u>
 with Convolutional Neural Networks and Transfer Learning
 - Used Mask Region-based CNN architecture for defect detection and segmentation in X-ray images, surpassing state-of-the-art performance.
 - Leveraged transfer learning to enhance prediction accuracy, enabling the model to excel in metal casting and welding quality assessment.
- <u>Detection and Segmentation of Manufacturing Defects</u> <u>with Convolutional Neural Networks and Transfer Learning</u>
 - Automated defect management system based on ML and computer vision for porcelain products developed with an industrial producer.
 - Utilizes a CNN to analyze product images, predicting defects, leading to improved production efficiency and reduced costs.
- Automatic localization of casting defects with convolutional neural networks
 - Explored various CNN architectures for localization of casting defects in X-ray images.
 - Leveraged transfer learning so as to train state-of-the-art CNN models on a relatively smaller dataset and compare their accuracy and computational performance.

Made by: Swapnoneel Kayal

Technical Resources

Open Libraries

- OpenCV
- Keras / PyTorch
- PIL (pillow)
- Statsmodel
- Scikitlearn (confusion matrices, etc)

Proprietary Libraries

None Available

Github and other resources

- "Product Fault Detection Using Transfer Learning" on Kaggle
- "Surface Steel Defect Detection" on Kaggle
- "Steel Surface Defect Detection Using UNet" on Github

Made by : Anand Bhaskar

Data

For defect detection: Casting Product Image Data

Size of the data: 300*300 pixels grey-scaled 7348

augmented images

Column details and data type: We are not dealing with tabular data. However, the dataset already splits the data for training and testing by separating the images into 2 separate folders (train and test). Both these folders contains def_front and ok_front subfolders.

Authenticity, error, bias and missing data: The dataset has been collected in stable lighting environment with extra arrangement. The data is authentic and no errors / missing data has been reported yet. The dataset is licensed

For defect classification: Metal surface defects dataset

Size of the data: This database includes 1800 grayscale images: 300 samples each for the six different kinds of typical surface defects

Column details and data type: We are not dealing with tabular data. However, the directory contains three folders i.e. train, valid amd test. The train folder contains six subfolders that have 276 image files in each folder. Accordingly, the test and valid contains six subfolders that have 12 images in each folder

Authenticity, error, bias and missing data: The dataset was downloaded from NEU Metal Surface Defects Database. Hence, the data is authentic and no errors / missing data has been reported yet.

Made by : Kanika Banjare

AI/ML model scheme

Object Detection + Defect Detection

- To detect the presence of pump impellers in images, we will fine-tune RetinaNet (with ResNet50 backbone). This model is used to detect & segment out the pump impellers so that the defects can be detected in them. This is followed by a model used to detect the presence/absence of defect (any kind) in a submersible pump impeller using Transfer Learning (with VGG16 base model)
- For the Object Detection model, training has been performed with a batch size of 20 using Adam
 Optimizer. We plan to first train the model for 200 epochs. For the Defect Detection model, training
 has been performed with a batch size of 50 using Adam Optimizer. We plan to first train the model
 for 10 epochs. The validation dataset was leveraged to tune the hyper-parameters of our model and
 the testing dataset was used subsequently to give an unbiased evaluation of our end model.
- Our model is relatively flexible due to the fact that we will be training our model on images that have been pre-processed (rescaled, sheared, rotated etc). This increases the model's ability to handle variations in the input data.

Made by: Shraman Santara

AI/ML model scheme

Defect Classification

- The AI/ML model chosen for the task is the VGG16 architecture, selected for its superior performance over ResNet50 for the specific defect classification task
- Training is performed with a batch size of 36 using Adam Optimizer. We plan to first train the model for 10 epochs. We will leverage the validation dataset to tune the hyper-parameters of our model and the testing dataset will help us give an unbiased evaluation of our end model.
- Our model is more on the rigid side as it is focused on a specific task of defect classification in metal surfaces